

Search Notes

Application/Control No.

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Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

FABRITIUS, HENNA

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	702	3/29/2007	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	as above	3/29/2007	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
s. sax	3/29/2007	LEE